Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,265	JANKE ET AL.	
Examiner	Art Unit	
Tongoc Tran	2134	

SEARCHED					
Class	Subclass	Date	Examiner		
726	34	6/22/2007	π		
713	193,194	6/22/2007	π		
712	223-227	6/22/2007	π		
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INTERFERENCE SEARCHED					
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726	. 34	6/22/2007	π		
713	193,194	6/22/2007	π		
712	223-227	6/22/2007	ΤΤ		

(INCLUDING SEAF	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
East	6/22/2007	т		
Inventor name search	6/22/2007	тт		
ACM	6/22/2007	тт		
Google	6/22/2007	тт		